Application/Control No. Applicant(s)/Patent Under Reexamination 09/821,492 REUTHER ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1764 Hien Tran **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 60/276 US-5,138,834 08-1992 Maund et al. Α 422/177 12-1999 Buck et al. В US-6,001,314 422/179 04-2003 Kruger, Klaus Gerhard US-6,555,070 С D US-US-Ε F US-G US-USн US-1 J US-Κ US-L US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY WO Dillon et al 12-1997 WO 97/48890 Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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